Application/Control No. Applicant(s)/Patent Under Reexamination 10/621,970 GRAF ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3767 Mark K. Han **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 01-2003 Musick et al. 604/218 US-2003/0004467 A1 Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS**

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